

Notice of References Cited	Application/Control No. 10/762,724	Applicant(s)/Patent Under Reexamination OUDERKIRK ET AL.	
	Examiner Mariceli Santiago	Art Unit 2879	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-6,464,366	10-2002	Lin et al.	362/616
*	C	US-2003/0189832	10-2003	Rizkin et al.	362/302
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NON-PATENT DOCUMENTS

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	U	
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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